

Silicon N-Channel Power MOSFET

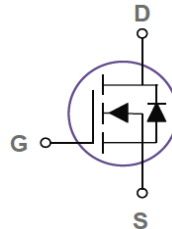
Preliminary

Features

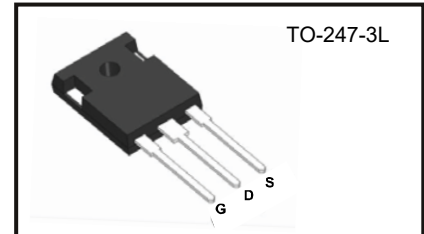
- Fast Switching
- Low On-Resistance
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode
- 100% Single Pulse Avalanche Energy Test

Applications

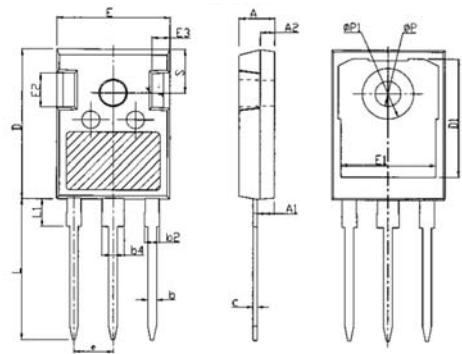
- Adaptor
- Charger
- SMPS Standby Power



V_{DSS}	1500V
$I_D(@25^{\circ}C)$	4A
$R_{DS(ON)}$ typ.	3.8 Ω



Package Dimensions



Absolute Maximum Ratings

($T_c = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Drain Source Voltage	V_{DS}	1500	V
Gate Source Voltage	V_{GS}	± 30	V
Drain Current Continuous @ $T_c = 25^{\circ}C$ @ $T_c = 100^{\circ}C$	I_D	4 2.6	A
Drain Current Pulsed	I_{DM}	16	A
Single Pulse Avalanche Energy	E_{AS}	130	mJ
Power Dissipation @ $T_c = 25^{\circ}C$	P_D	250	W
Storage Temperature Range	T_{STG}	-55 to +150	$^{\circ}C$
Operating Junction Temperature Range	T_J	-55to +150	$^{\circ}C$
Thermal Resistance Junction to Case	$R_{\theta Jc}$	0.5	$^{\circ}C/W$
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	50	$^{\circ}C/W$

UNIT:mm			
Symbol	Min.	Nom	Max.
A	4.80	5.00	5.20
A1	2.21	2.41	2.61
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
b4	2.91	3.01	3.21
c	0.51	0.61	0.75
D	20.70	21.00	21.30
D1	16.25	16.55	16.85
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.80	5.00	5.20
E3	2.30	2.50	2.70
e	5.44BSC		
L	19.62	19.92	20.22
L1	-	-	4.30
ϕP	3.40	3.60	3.80
$\phi P1$	-	-	7.30
S	6.15BSC		

Electrical Characteristics @ T_c =25°C (unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
OFF Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V , I _{DS} =0.25mA	1500	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} =0V , V _{DS} =1500V	-	-	10	μA
Gate To Source Forward Leakage	I _{GSS(F)}	V _{GS} =±30V , V _{DS} =0V	-	-	±100	nA
ON Characteristics						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _{DS} =0.25mA	2.5	-	4.5	V
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} =10V , I _{DS} =2A	-	3.8	5	Ω
Forward Transconductance	g _{fs}	V _{DS} =15V , I _D =2A	-	2.4	-	S
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{DS} =25V	-	3230	-	pF
Output Capacitance	C _{oss}	V _{GS} =0V	-	150	-	
Reverse Transfer Capacitance	C _{rss}	Freq.=1MHz	-	20	-	
Switching Characteristics						
Turn-On Delay Time	t _{d(on)}	V _{DD} =750V	-	55	-	ns
Rise Time	t _r	V _{GS} =10V	-	27	-	
Turn-Off Delay Time	t _{d(off)}	I _D =4A	-	95	-	
Fall Time	t _f	R _G =10Ω	-	45	-	
Total Gate Charge	Q _g	V _{DS} =750V	-	60	-	nC
Gate to Source Charge	Q _{gs}	V _{GS} =10V	-	16	-	
Gate to Drain Charge	Q _{gd}	I _{DS} =4A	-	24	-	
Source-Drain Diode Characteristics						
Diode Forward Voltage	V _{SD}	V _{GS} =0V , I _S =4A	-	-	1.5	V
Continuous Source Current (Body Diode)	I _{SD}		-	-	4	A
Max. Pulsed Current (Body Diode)	I _{SM}		-	-	16	A
Reverse Recovery Time	T _{rr}	V _{GS} =0V I _S =4A , T _J =25°C	-	400	-	ns
Reverse Recovery Charge	Q _{rr}	di _r /dt=100A/μs	-	2.2	-	μC

*Pulse Width < 380 μs, Duty Cycle < 2%.

Typical Performance Characteristics

Fig. 1. Output Characteristics @ $T_J = 25^\circ\text{C}$

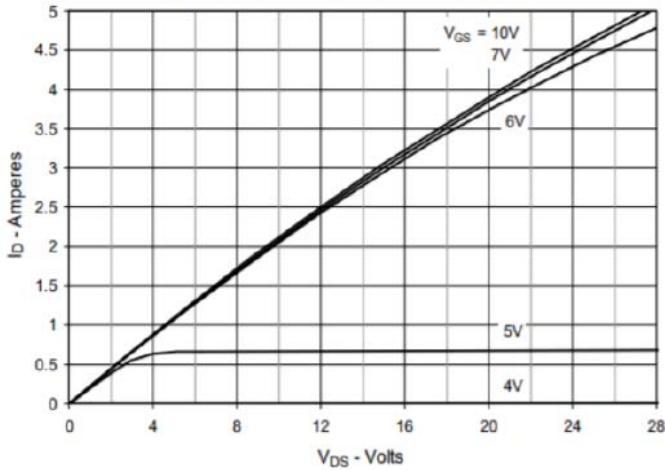


Fig. 2. Output Characteristics @ $T_J = 125^\circ\text{C}$

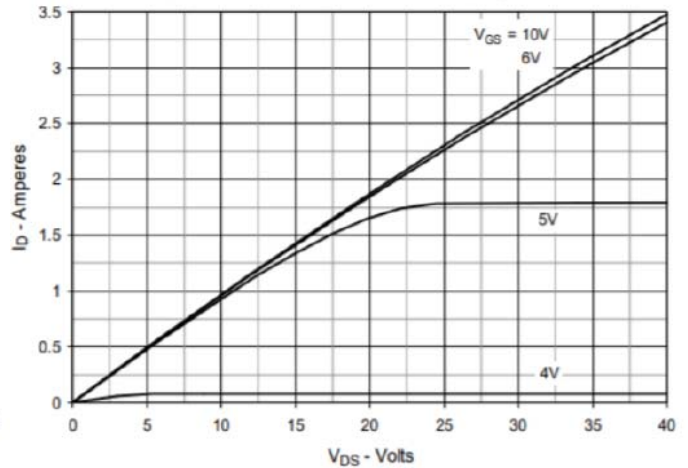


Fig. 3. $R_{DS(on)}$ Normalized to $I_D = 2\text{A}$ Value vs. Junction Temperature

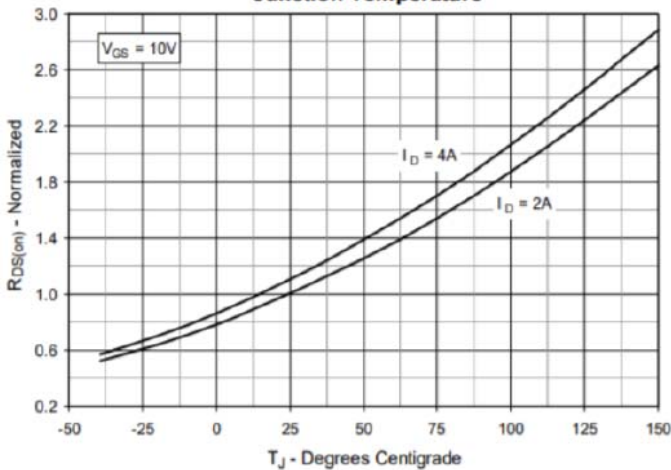


Fig. 4. $R_{DS(on)}$ Normalized to $I_D = 2\text{A}$ Value vs. Drain Current

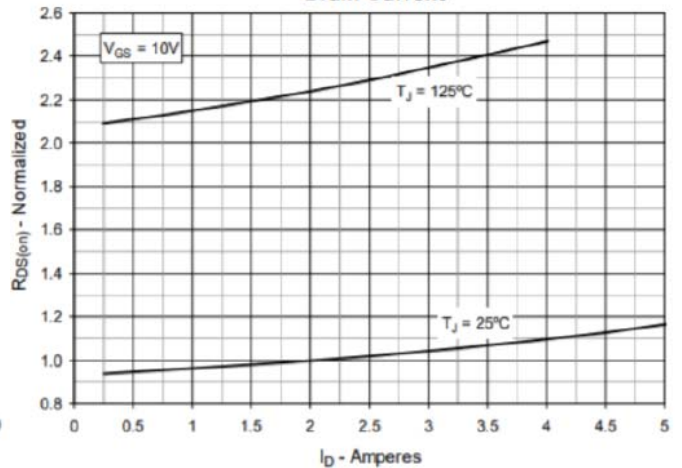


Fig. 5. Maximum Drain Current vs. Case Temperature

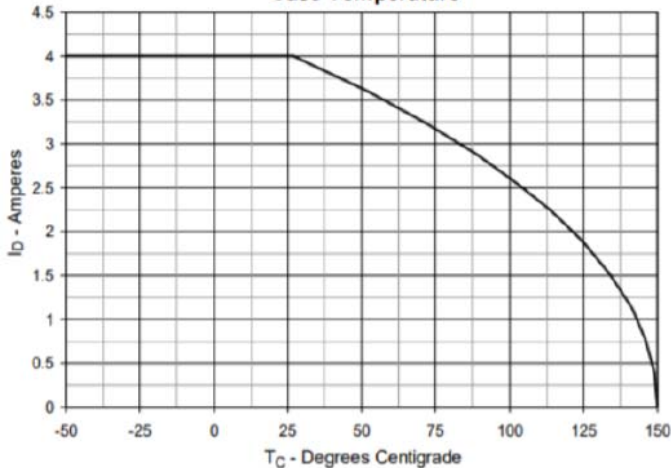
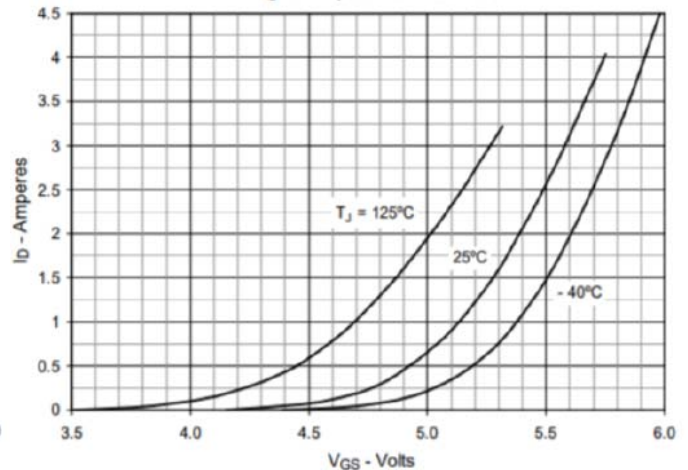


Fig. 6. Input Admittance



Typical Performance Characteristics

Fig. 7. Transconductance

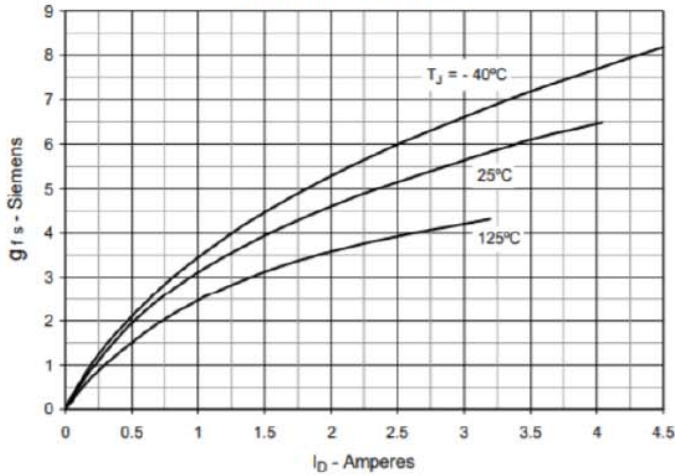


Fig. 8. Forward Voltage Drop of Intrinsic Diode

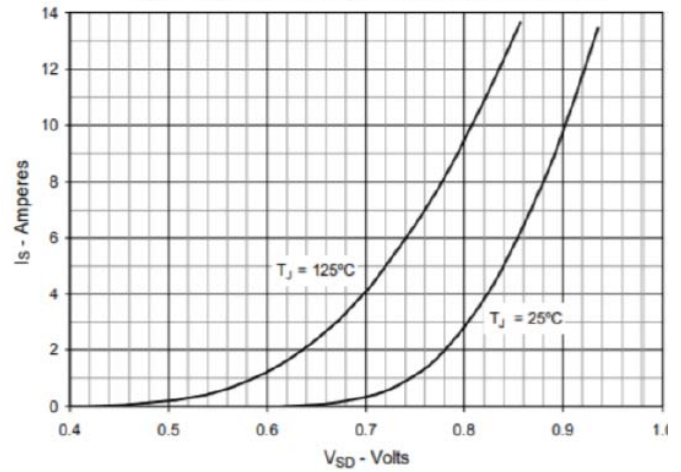


Fig. 9. Gate Charge

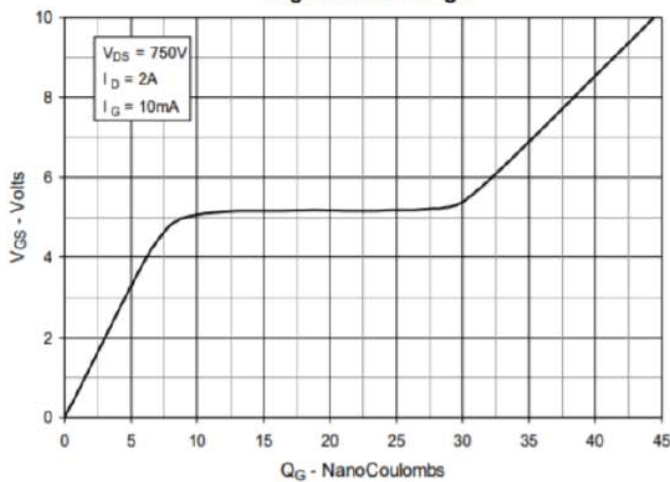


Fig. 10. Capacitance

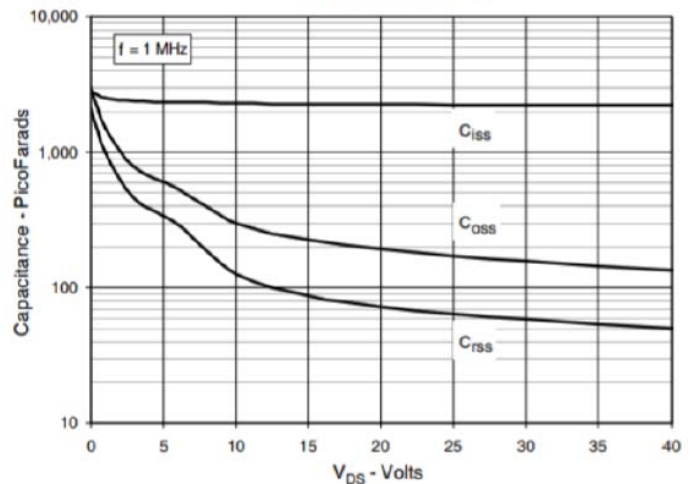


Fig. 11. Breakdown and Threshold Voltages vs. Junction Temperature

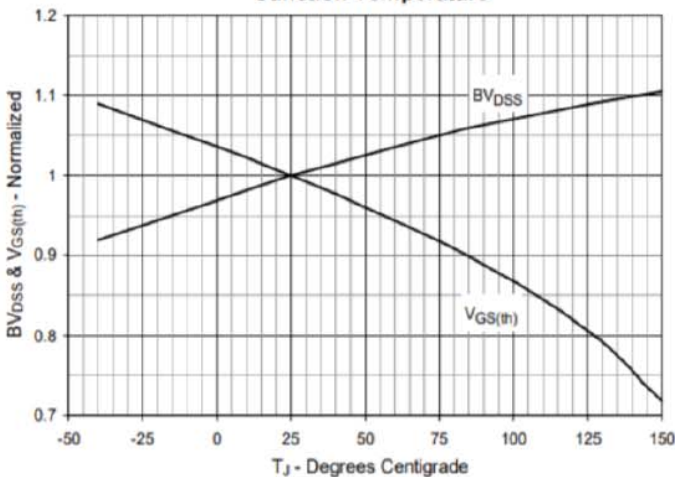
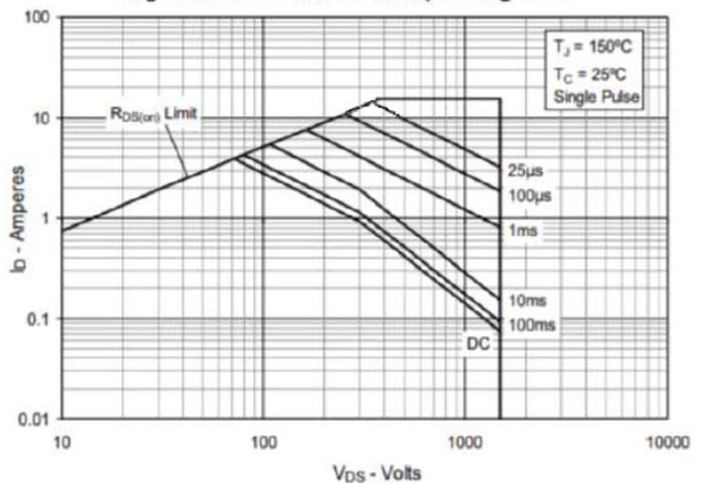
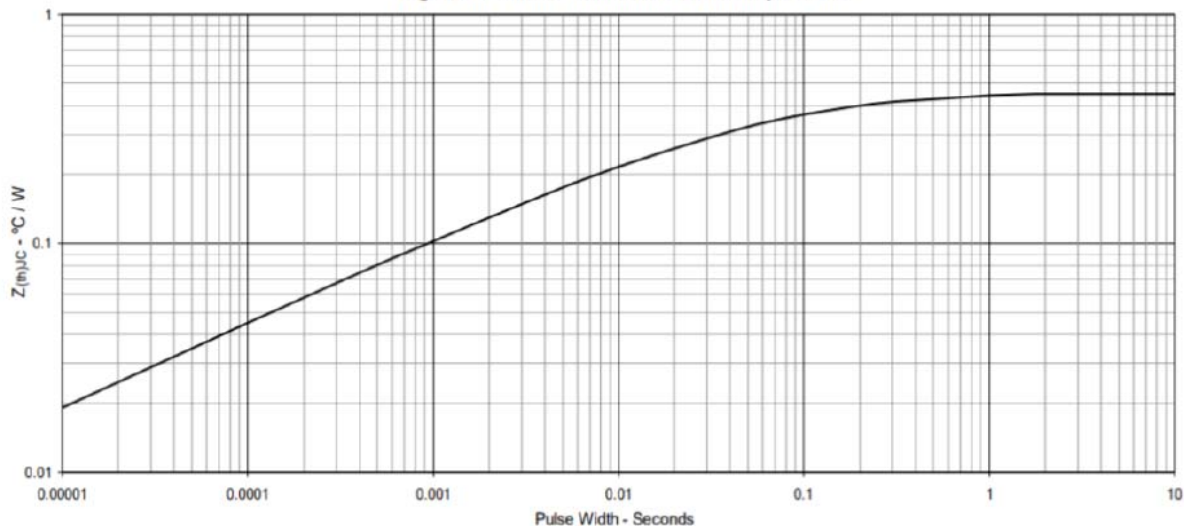


Fig. 12. Forward-Bias Safe Operating Area



Typical Performance Characteristics

Fig. 13. Maximum Transient Thermal Impedance



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